

**Search Notes**

Application/Control No.

10/657,122

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

WANG, HANK

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	381	5/24/2005	SHL
235	475	5/24/2005	SHL
235	492	5/24/2005	SHL
902	29	5/24/2005	SHL
29	831	5/24/2005	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	5/24/2005	SHL
NPL	5/24/2005	SHL
PCT cites	5/24/2005	SHL
S. Paik (235)	5/24/2005	SHL